

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2459	SERIAL NO. 10/728,977
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Belford T. Coursey	
				FILING DATE 12/08/2003	GROUP 2811

U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
	AA	6,589,876	07/2003	Tran	438	700	
	AB						
	AC						
	AD						
	AE						
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	AH						
	AI						

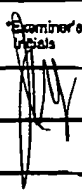
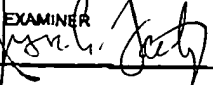
FOREIGN PATENT DOCUMENTS							
Document Number	Date	Country	Class	Subclass	Translation		
					Yes	No	
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
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EXAMINER:	DATE CONSIDERED: 03/20/05
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

EV 372458765

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2459		SERIAL NO. 10/728,977		
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Belford T. Coursey				
				FILING DATE December 8, 2003		GROUP 2811		
U.S. PATENT DOCUMENTS								
Examiner's Initials		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
	AA	6,376,304 B1	04/23/02	Matsuoka et al.				
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation	
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EXAMINER 		DATE CONSIDERED 03/20/05						
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Sheet 1 of 4

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2459		PRIORITY SERIAL NO. 40241245 16/728977	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Belford T. Coursey			
				PRIORITY FILING DATE September 10, 2002		PRIORITY GROUP ART UNTL 2812	

U.S. PATENT DOCUMENTS								
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
[Signature]	AA	4,978,009	01/22/91	Flanner				
	AB	4,996,627	02/26/91	Zias et al.				
	AC	5,023,683	06/11/91	Yamada				
	AD	5,032,882	07/16/91	Okumura et al.				
	AE	5,061,650	10/29/91	Dennison et al.				
	AF	5,084,414	01/28/92	Manley et al.				
	AG	5,087,591	02/11/92	Teng				
	AH	5,120,679	06/09/92	Boardman et al.				
	AI	5,138,412	08/11/92	Hieda et al.				
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
[Signature]	AL	2528608	06/14/96	Japan (Micron)				
	AK	2-275665	11/09/90	Japan				
	AL	3-174765	07/29/91	Japan				
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
[Signature]	AM	Fujii et al., <i>ULSI DRAM Technology With Ba_{0.7}Sr_{0.3}TiO₃ Film of 1.3 nm Equivalent SiO₂ Thickness and 10⁻⁹ A/cm² Leakage Current</i> , IEEE 267-270 (1992).						
[Signature]	AN	IBM Tech Bulletin, <i>Stacked Capacitor DRAM Cell With Vertical Fins (VF-STC)</i> , 33 IBM TECHNICAL DISCLOSURE						
		Bulletin, No. 2, pp. 245-247 (July 1990).						
[Signature]	AO	Kaga et al., <i>Crown-Shaped Stacked-Capacitor Cell for 1.5-V Operation 64-Mb DRAM's</i> , 38 TRANSACTIONS ON						
		ELECTRON DEVICES, No. 2, pp. 255-260 (February 1991).						
EXAMINER [Signature]		DATE CONSIDERED 03/01/05						
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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Belford T. Coursey 10/728977			
				PRIORITY FILING DATE September 10, 2002		PRIORITY GROUP ART UNTI 2813	

U.S. PATENT DOCUMENTS							
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
	AA	5,168,073	12/01/92	Gonzalez et al.			
	AB	5,206,183	04/27/93	Dennison			
	AC	5,250,457	10/05/93	Dennison			
	AD	5,770,499	06/23/98	Kwok et al.			
	AE	5,780,338	07/14/98	Jeng et al.			
	AF	5,990,021	11/23/99	Prall et al.			
	AG	5,998,257	12/07/99	Lane et al.			
	AH	6,030,879	02/29/00	Huang			
	AI	6,054,394	04/25/00	Wang			

FOREIGN PATENT DOCUMENTS								
Examiner's Initials	Class	Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AJ	4220497 A1	06/23/92	Germany (Samsung)				
	AK	4316503 A1	05/17/93	Germany (Micron)				
	AL							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)		
	AM	Kawamoto et al., A 1.28 μ m ² Bit-Line Shielded Memory Cell Technology for 64Mb DRAMs, IEEE 13-14 (1990 Symposium on VLSI Technology).
	AN	Ueno et al., A Quarter-Micron Planarized Interconnection Technology With Self-Aligned Plug, IEEE 305-308 (1992).
	AO	

EXAMINER:	DATE CONSIDERED: 3/24/05	
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LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Belford T. Coursey 10/728917			
				PRIORITY FILING DATE September 10, 2002		PRIORITY GROUP ART UNTI 2845	

U.S. PATENT DOCUMENTS							
Examiner's Initials	Class	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
[Signature]	AA	6,057,206	05/02/00	Nguyen et al.			
	AB	6,087,261	07/11/00	Nishikawa et al.			
	AC	6,114,201	09/05/00	Wu			
	AD	6,130,126	10/10/00	Iwakiri			
	AE	6,159,818	12/12/00	Durcan et al.			
	AF	6,200,898	03/13/01	Tu			
	AG	6,232,168	05/15/01	Coursey			
	AH	6,232,240	05/15/01	Tung			
	AI	6,258,729	07/10/01	DeBoer et al.			

FOREIGN PATENT DOCUMENTS								
Examiner's Initials	Class	Document Number	Date	Country	Class	Subclass	Translation	
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[Signature]	AJ							
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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)			
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Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. MI22-2459		PRIORITY SERIAL NO. 10/241,246 101728977	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT: Belford T. Coursey		PRIORITY FILING DATE September 10, 2002	
				PRIORITY GROUP ART UNTIL 2813			
U.S. PATENT DOCUMENTS							
Examiner's Initials	Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate	
	AA	6,376,380	04/23/02	Tang et al.			
	AB	6,395,600 B1	05/28/02	Durcan et al.			
	AC	6,426,243 B1	07/30/02	Coursey			
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FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
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EXAMINER		DATE CONSIDERED 03/25/05					
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